

DM74LS132

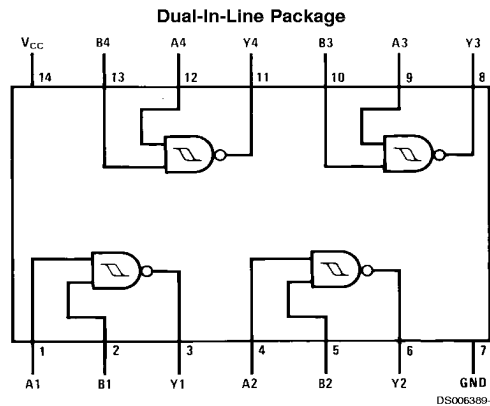
Quad 2-Input NAND Gates with Schmitt Trigger Inputs

General Description

This device contains four independent gates each of which performs the logic NAND function. Each input has hysteresis

which increases the noise immunity and transforms a slowly changing input signal to a fast changing, jitter free output.

Connection Diagram



Order Number DM54LS132J, DM54LS132W, DM74LS132M or DM74LS132N
See Package Number J14A, M14A, N14A or W14B

Function Table

$$Y = \overline{AB}$$

Inputs		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

H = High Logic Level
L = Low Logic Level

DM74LS132 Quad 2-Input NAND Gates with Schmitt Trigger Inputs

Absolute Maximum Ratings (Note 1)

Supply Voltage	7V	DM54LS	-55°C to +125°C
Input Voltage	7V	DM74LS	0°C to +70°C
Operating Free Air Temperature Range		Storage Temperature Range	-65°C to +150°C

Recommended Operating Conditions

Symbol	Parameter	DM54LS132			DM74LS132			Units
		Min	Nom	Max	Min	Nom	Max	
V _{CC}	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V
V _{T+}	Positive-Going Input Threshold Voltage (Note 2)	1.4	1.6	1.9	1.4	1.6	1.9	V
V _{T-}	Negative-Going Input Threshold Voltage (Note 2)	0.5	0.8	1	0.5	0.8	1	V
HYS	Input Hysteresis (Note 2)	0.4	0.8		0.4	0.8		V
I _{OH}	High Level Output Current			-0.4			-0.4	mA
I _{OL}	Low Level Output Current			4			8	mA
T _A	Free Air Operating Temperature	-55		125	0		70	°C

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Electrical Characteristics

over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ (Note 3)	Max	Units
V _I	Input Clamp Voltage	V _{CC} = Min, I _I = -18 mA			-1.5	V
V _{OH}	High Level Output Voltage	V _{CC} = Min, I _{OH} = Max, V _I = V _{T-} Min	DM54 2.5 DM74 2.7	3.4 3.4		V
V _{OL}	Low Level Output Voltage	V _{CC} = Min, I _{OL} = Max, V _I = V _{T+} Max	DM54 DM74	0.25 0.35	0.4 0.5	V
		I _{OL} = 4 mA, V _{CC} = Min	DM74	0.25	0.4	
I _{T+}	Input Current at Positive-Going Threshold	V _{CC} = 5V, V _I = V _{T+}		-0.14		mA
I _{T-}	Input Current at Negative-Going Threshold	V _{CC} = 5V, V _I = V _{T-}		-0.18		mA
I _I	Input Current @ Max Input Voltage	V _{CC} = Max, V _I = 7V			0.1	mA
I _{IH}	High Level Input Current	V _{CC} = Max, V _I = 2.7V			20	μA
I _{IL}	Low Level Input Current	V _{CC} = Max, V _I = 0.4V			-0.4	mA
I _{OS}	Short Circuit Output Current	V _{CC} = Max (Note 4)	DM54 DM74	-20 -20	-100 -100	mA
I _{CCH}	Supply Current with Outputs High	V _{CC} = Max		5.9	11	mA
I _{CCL}	Supply Current with Outputs Low	V _{CC} = Max		8.2	14	mA

Note 2: V_{CC} = 5V

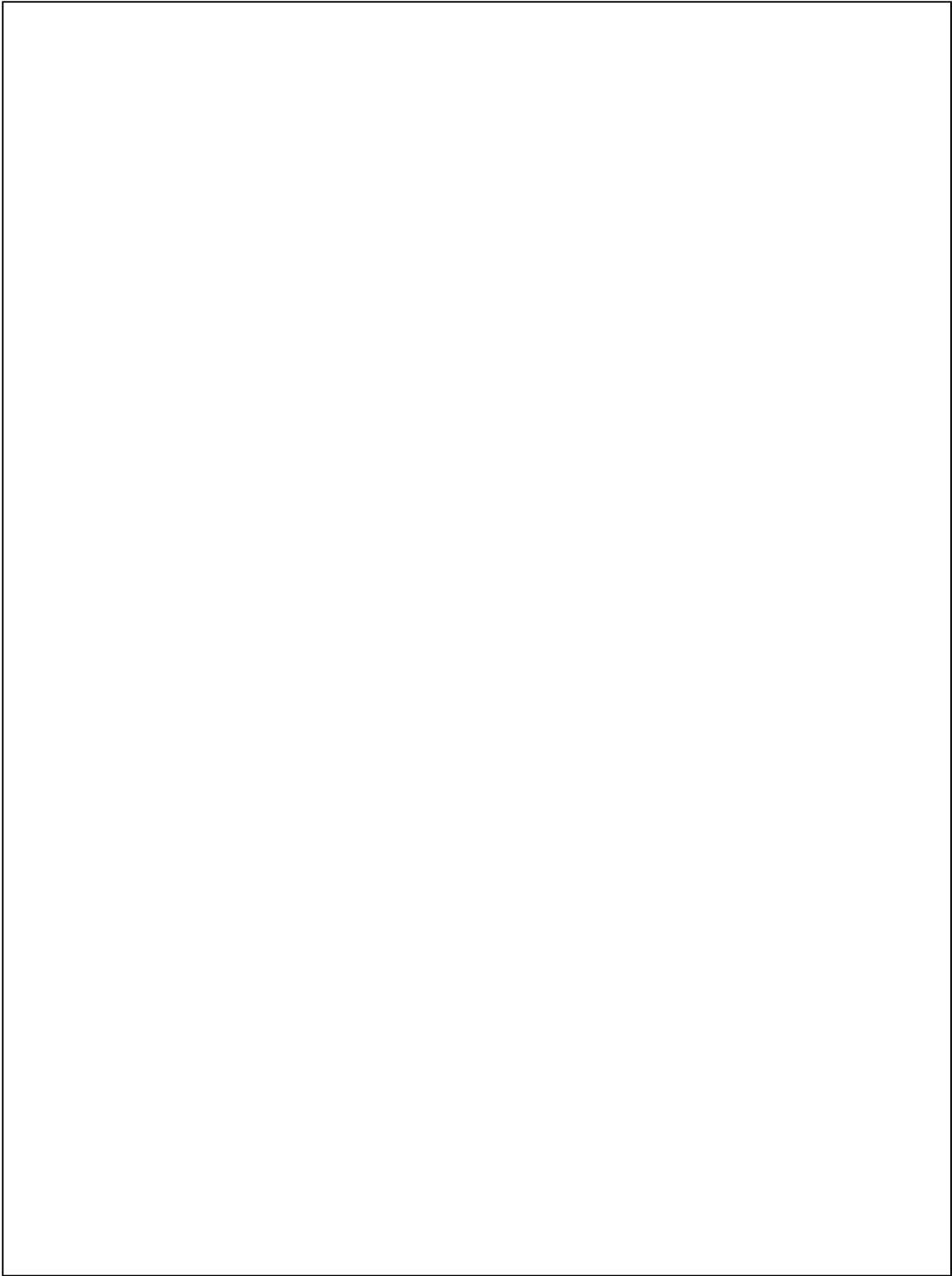
Note 3: All typicals are at V_{CC} = 5V, T_A = 25°C.

Note 4: Not more than one output should be shorted at a time, and the duration should not exceed one second.

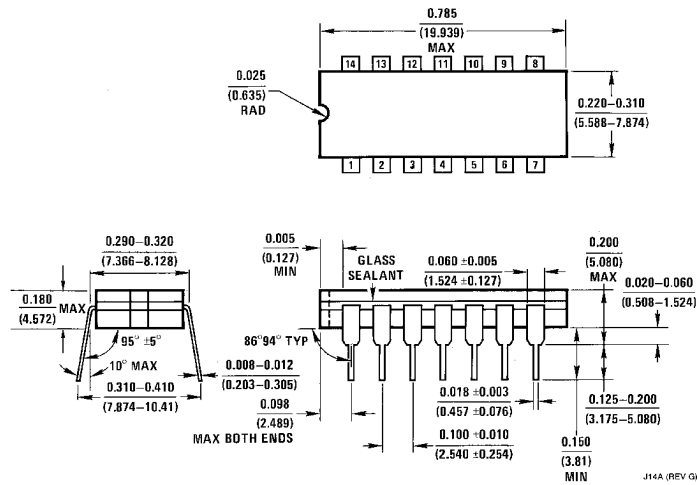
Switching Characteristics

at V_{CC} 5V and $T_A = 25^\circ\text{C}$

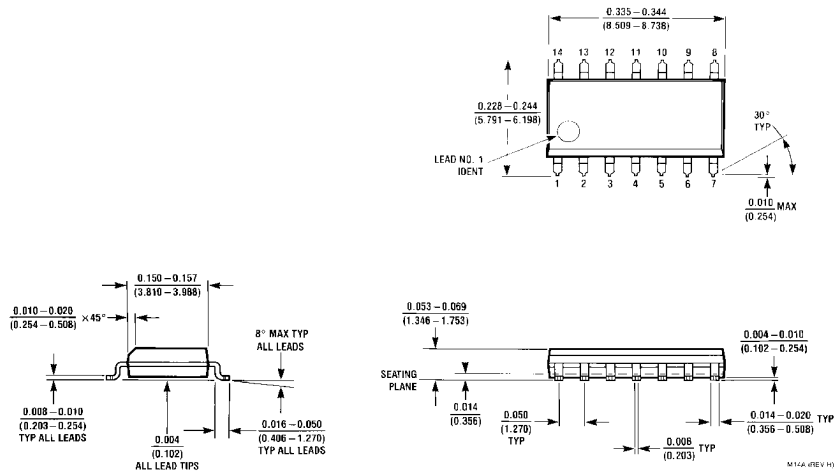
Symbol	Parameter	R _L = 2 kΩ				Units
		C _L = 15 pF		C _L = 50 pF		
		Min	Max	Min	Max	
t _{PLH}	Propagation Delay Time Low to High Level Output	5	22	8	25	ns
t _{PHL}	Propagation Delay Time High to Low Level Output	5	22	10	33	ns



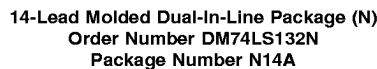
Physical Dimensions inches (millimeters) unless otherwise noted



14-Lead Ceramic Dual-In-Line Package (J)
Order Number DM54LS132J
Package Number J14A



14-Lead Small Outline Molded Package (M)
Order Number DM74LS132M
Package Number M14A



1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

**National Semiconductor
Japan Ltd.**
Tel: 81-3-5620-6175
Fax: 81-3-5620-6179

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